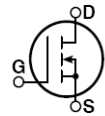

 Common  
 Source


# RF POWER MOSFETs

## N-CHANNEL ENHANCEMENT MODE

**300V 150W 60MHz**

The ARF465A and 465B comprise a symmetric pair of common source RF power transistors designed for push-pull scientific, commercial, medical and industrial RF power amplifier applications up to 60 MHz.

• **Specified 300 Volt, 40.68 MHz Characteristics:**

**Output Power = 150 Watts.**

**Gain = 13dB (Class C)**

**Efficiency = 75%**

• **Low Cost Common Source RF Package.**

• **Low  $V_{th}$  thermal coefficient.**

• **Low Thermal Resistance.**

• **Optimized SOA for Superior Ruggedness.**


### MAXIMUM RATINGS

 All Ratings:  $T_C = 25^\circ\text{C}$  unless otherwise specified.

| Symbol          | Parameter   | ARF465A/B(G) | UNIT               |
|-----------------|---|--------------|--------------------|
| $V_{DSS}$       | Drain-Source Voltage                                | 1200         | Volts              |
| $V_{DGO}$       | Drain-Gate Voltage                                  | 1200         |                    |
| $I_D$           | Continuous Drain Current @ $T_C = 25^\circ\text{C}$ | 6            | Amps               |
| $V_{GS}$        | Gate-Source Voltage                                 | $\pm 30$     | Volts              |
| $P_D$           | Total Power Dissipation @ $T_C = 25^\circ\text{C}$  | 250          | Watts              |
| $R_{\theta JC}$ | Junction to Case                                    | 0.50         | $^\circ\text{C/W}$ |
| $T_J, T_{STG}$  | Operating and Storage Junction Temperature Range    | -55 to 150   | $^\circ\text{C}$   |
| $T_L$           | Lead Temperature: 0.063" from Case for 10 Sec.      | 300          |                    |

### STATIC ELECTRICAL CHARACTERISTICS

| Symbol       | Characteristic / Test Conditions   | MIN  | TYP | MAX       | UNIT          |
|--------------|--|------|-----|-----------|---------------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage ( $V_{GS} = 0V, I_D = 250 \mu\text{A}$ )                          | 1200 |     |           | Volts         |
| $V_{DS(ON)}$ | On State Drain Voltage <sup>①</sup> ( $I_D(ON) = 3A, V_{GS} = 10V$ )                             |      |     | 8         |               |
| $I_{DSS}$    | Zero Gate Voltage Drain Current ( $V_{DS} = V_{DSS}, V_{GS} = 0V$ )                              |      |     | 25        | $\mu\text{A}$ |
|              | Zero Gate Voltage Drain Current ( $V_{DS} = 0.8 V_{DSS}, V_{GS} = 0V, T_C = 125^\circ\text{C}$ ) |      |     | 250       |               |
| $I_{GSS}$    | Gate-Source Leakage Current ( $V_{GS} = \pm 30V, V_{DS} = 0V$ )                                  |      |     | $\pm 100$ | nA            |
| $g_{fs}$     | Forward Transconductance ( $V_{DS} = 25V, I_D = 3A$ )  | 3    | 4   |           | mhos          |
| $V_{GS(TH)}$ | Gate Threshold Voltage ( $V_{DS} = V_{GS}, I_D = 50\text{mA}$ )                                  | 3    |     | 5         | Volts         |

 **CAUTION:** These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

## DYNAMIC CHARACTERISTICS

ARF465A/B(G)

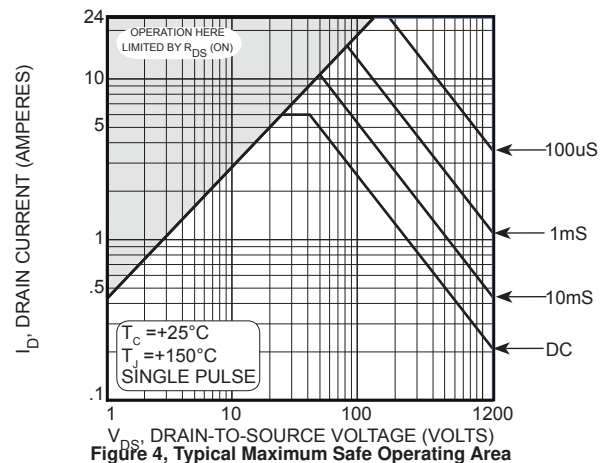
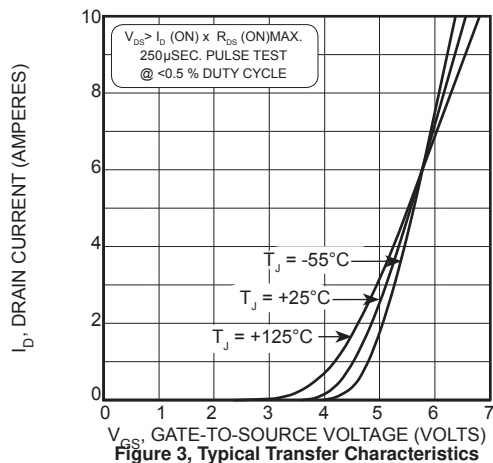
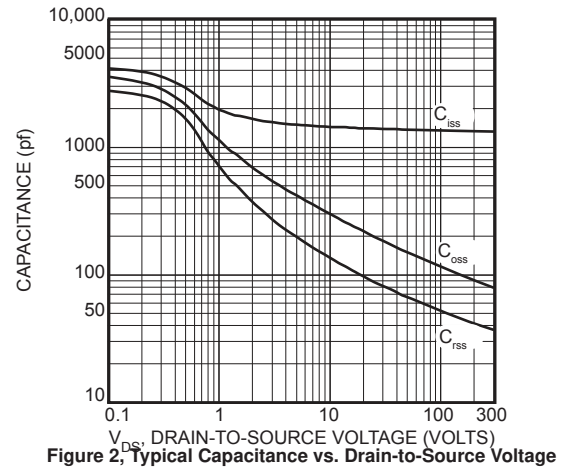
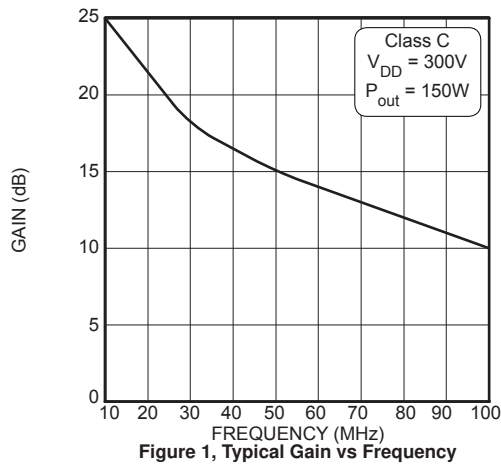
| Symbol       | Characteristic               | Test Conditions  | MIN | TYP  | MAX  | UNIT |
|--------------|------------------------------|--|-----|------|------|------|
| $C_{iss}$    | Input Capacitance            | $V_{GS} = 0V$<br>$V_{DS} = 200V$<br>$f = 1\text{ MHz}$                                 |     | 1200 | 1500 | pF   |
| $C_{oss}$    | Output Capacitance           |  |     | 80   | 100  |      |
| $C_{rss}$    | Reverse Transfer Capacitance |  |     | 30   | 50   |      |
| $t_{d(on)}$  | Turn-on Delay Time           | $V_{GS} = 15V$<br>$V_{DD} = 0.5V$<br>$I_D = I_{D[Cont.]} @ 25^\circ C$<br>$R_G = 1.6W$ |     | 7    | 15   | ns   |
| $t_r$        | Rise Time                    |  |     | 5    | 10   |      |
| $t_{d(off)}$ | Turn-off Delay Time          |  |     | 21   | 34   |      |
| $t_f$        | Fall Time                    |  |     | 12   | 25   |      |

## FUNCTIONAL CHARACTERISTICS

| Symbol   | Characteristic                     | Test Conditions               | MIN                            | TYP | MAX | UNIT |
|----------|------------------------------------|-------------------------------|--------------------------------|-----|-----|------|
| $G_{PS}$ | Common Source Amplifier Power Gain | $f = 40.68\text{ MHz}$        | 13                             | 15  |     | dB   |
| $\eta$   | Drain Efficiency                   | $V_{GS} = 0V$ $V_{DD} = 300V$ | 70                             | 75  |     | %    |
| $\Psi$   | Electrical Ruggedness VSWR 6:1     | $P_{out} = 150W$              | No Degradation in Output Power |     |     |      |

① Pulse Test: Pulse width < 380  $\mu$ S, Duty Cycle < 2%

Microsemi Reserves the right to change, without notice, the specifications and information contained herein.



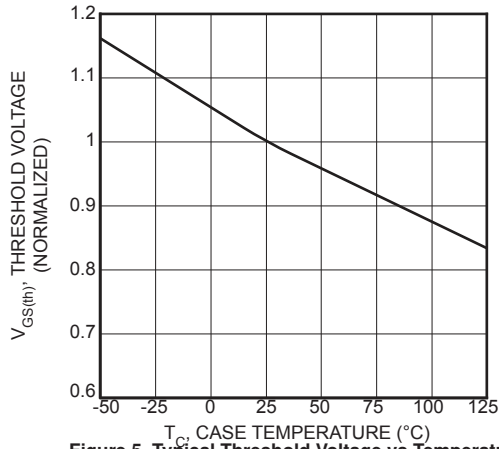


Figure 5, Typical Threshold Voltage vs Temperature

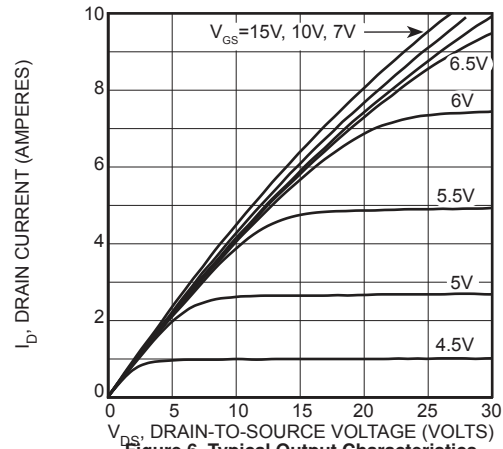


Figure 6, Typical Output Characteristics

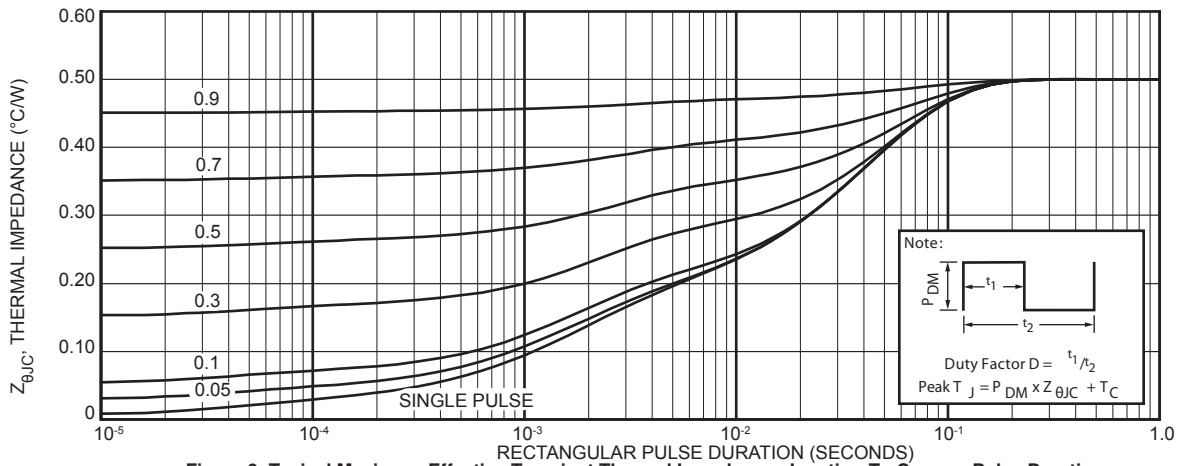


Figure 9, Typical Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration

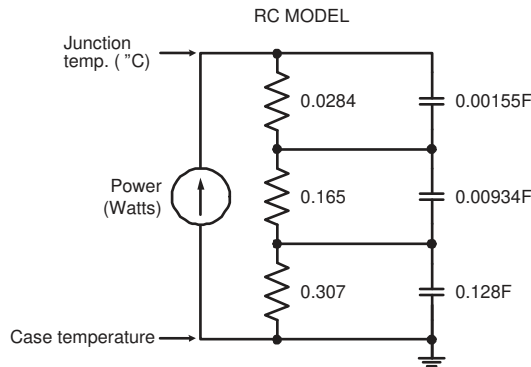


Figure 9a, TRANSIENT THERMAL IMPEDANCE MODEL

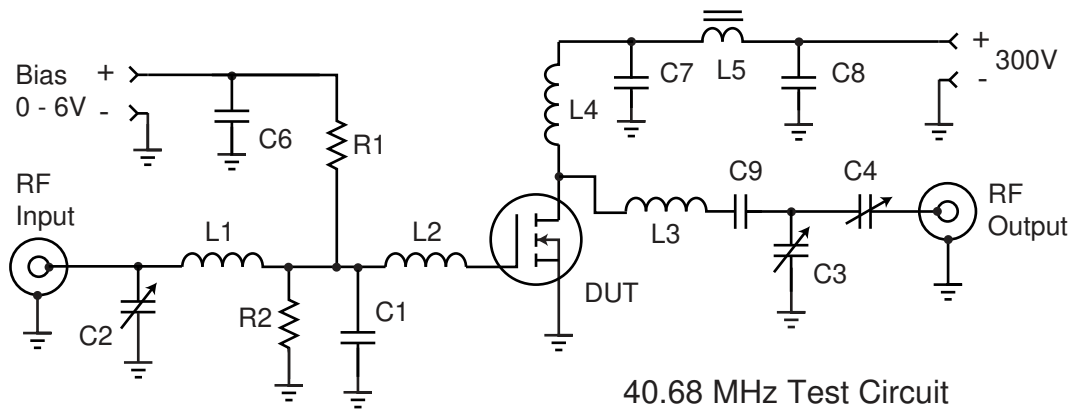
Table 1 - Typical Class AB Large Signal input - Output Impedance

| Freq. (MHz) | Z <sub>in</sub> (Ω) | Z <sub>OL</sub> (Ω) |
|-------------|---------------------|---------------------|
| 2.0         | 21.4 - j 8.7        | 206 - j 45          |
| 13.5        | 2.6 - j 7.3         | 68 - j 99           |
| 27          | .54 - j 2.9         | 22 - j 64           |
| 40          | .22 - j .69         | 10.5 - j 44         |
| 65          | .31 + j 1.65        | 4.4 - j 27          |

Z<sub>in</sub> - Gate shunted with 25Ω

I<sub>DQ</sub> = 100mA

Z<sub>OL</sub> - Conjugate of optimum load for 150 Watts output at V<sub>dd</sub> = 300V

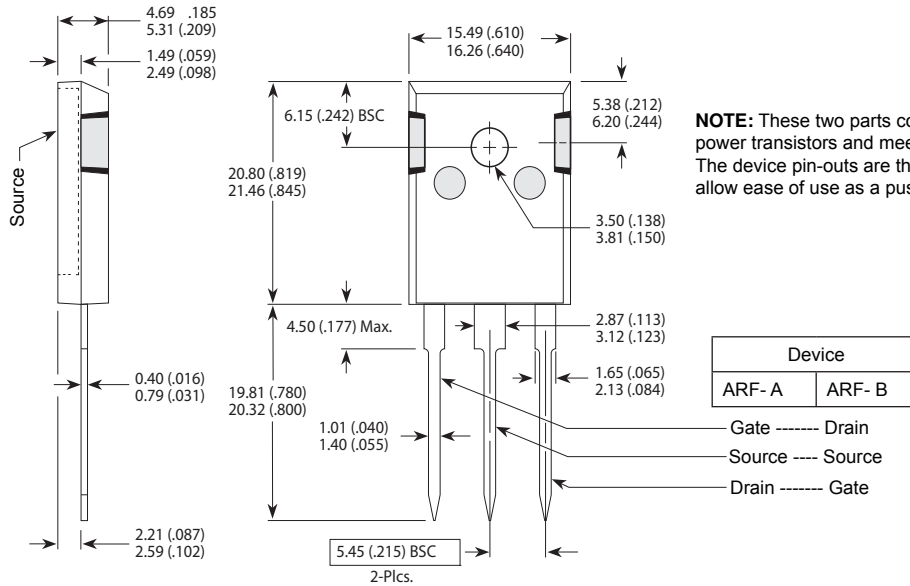


40.68 MHz Test Circuit

- C1 - 1000pF 100V chip ATC 700B
- C2-C5 - Arco 463 Mica trimmer
- C6-C8 - .01  $\mu$ F 500V ceramic chip
- C9 - 2200 pF COG 500 V chip
- L1 - 4t #20 AWG .25"ID .3"L ~110 nH
- L2 - 2t #20 AWG .25"ID .3"L ~ 25 nH

- L3-- 4t #16 AWG .4" ID .5"L ~290 nH
- L4 -- 25t #24 AWG .35"ID ~2uH
- L5-- VK200-4B ferrite choke 3uH
- R1-R2 -- 51 Ohm 0.5W Carbon
- DUT = ARF465A/B

TO-247 Package Outline



Dimensions in Millimeters and (Inches)

HAZARDOUS MATERIAL WARNING:

The ceramic portion of the device between leads and mounting flange is beryllium oxide. Beryllium oxide dust is highly toxic when inhaled. Care must be taken during handling and mounting to avoid damage to this area. These devices must never be thrown away with general industrial or domestic waste.

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